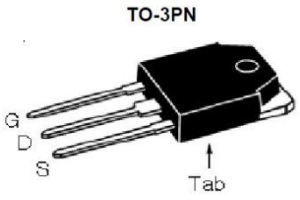
TMAN23N50

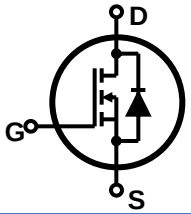
N-channel MOSFET

BV_{DSS}	I_D	$R_{DS(on)MAX}$
500V	23A	<0.22Ω

Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- JEDEC Qualification





Device	Package	Marking	Remark
TMAN23N50	TO-3P	TMAN23N50	RoHS

Absolute Maximum Ratings

Parameter		Symbol	TMAN23N50	Unit
Drain-Source Voltage		V_{DS}	500	V
Gate-Source Voltage		V_{GS}	±30	V
Continuous Drain Current	T_C = 25 ℃	I_D	23	A
	T_C = 100 ℃		14.5	A
Pulsed Drain Current (Note 1)		I_{DM}	92	A
Single Pulse Avalanche Energy (Note 2)		E_{AS}	970	mJ
Repetitive Avalanche Current (Note 1)		I_{AR}	23	A
Repetitive Avalanche Energy (Note 1)		E_{AR}	34.7	mJ
Power Dissipation	T_C = 25 ℃	P_D	347	W
	Derate above 25 ℃		2.77	W/℃
Peak Diode Recovery dv/dt (Note 3)		dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range		T_J, T_{STG}	-55~150	℃
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		T_L	300	℃

* Limited only by maximum junction temperature

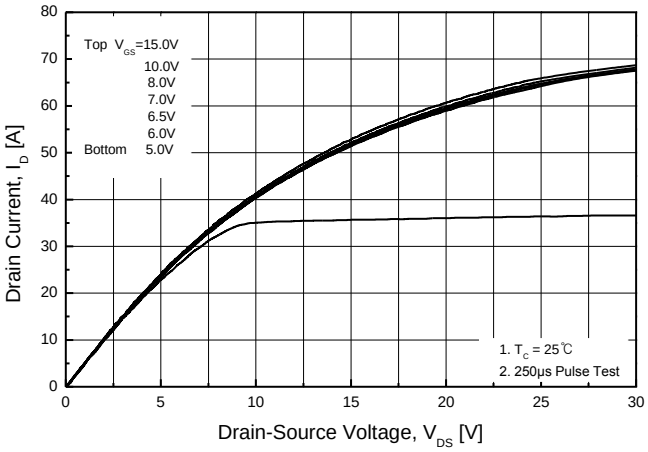
Thermal Characteristics

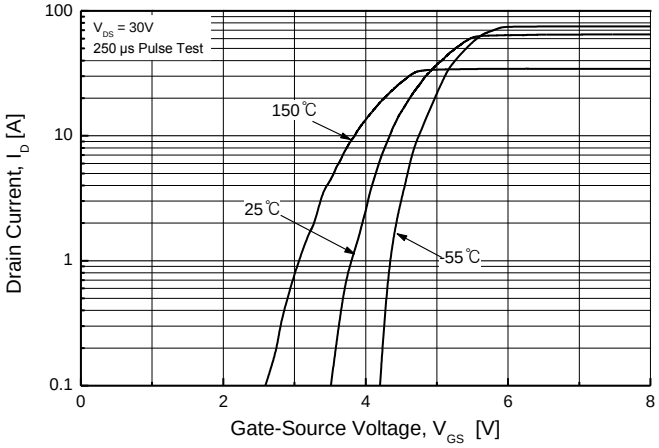
Parameter	Symbol	TMAN23N50	Unit
Maximum Thermal resistance, Junction-to-Case	$R_{\theta JC}$	0.36	℃/W
Maximum Thermal resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	℃/W

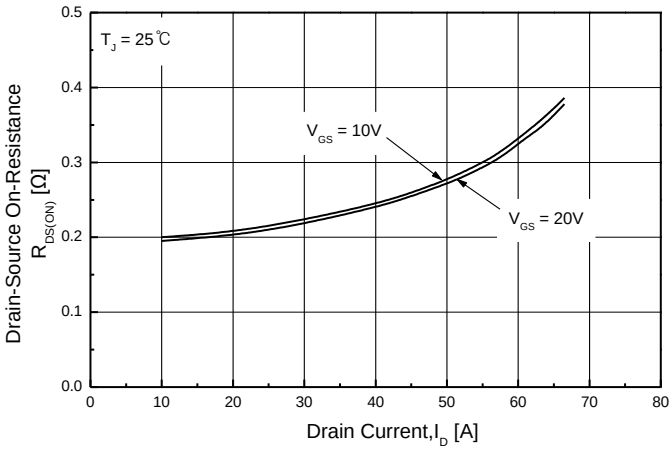
Electrical Characteristics : T_C=25℃, unless otherwise noted

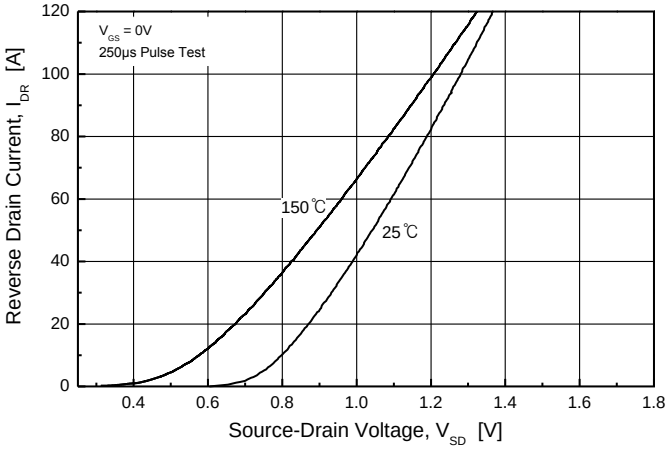
Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} = 0 V, I_D = 250 µA	500	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 500 V, V_{GS} = 0 V	--	--	1	µA
		V_{DS} = 400 V, T_C = 125°C	--	--	10	µA
Forward Gate-Source Leakage Current	I_{GSSF}	V_{GS} = 30 V, V_{DS} = 0 V	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	V_{GS} = -30 V, V_{DS} = 0 V	--	--	-100	nA
ON						
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250 µA	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	V_{GS} = 10 V, I_D = 11.5 A	--	0.185	0.22	Ω
Forward Transconductance (Note 4)	g_{FS}	V_{DS} = 30 V, I_D = 11.5 A	--	28	--	S
DYNAMIC						
Input Capacitance	C_{iss}	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz	--	3391	--	pF
Output Capacitance	C_{oss}		--	357	--	pF
Reverse Transfer Capacitance	C_{rss}		--	14	--	pF
SWITCHING						
Turn-On Delay Time (Note 4,5)	$t_{d(on)}$	V_{DD} = 250 V, I_D = 23 A, R_G = 25 Ω	--	78	--	ns
Turn-On Rise Time (Note 4,5)	t_r		--	64	--	ns
Turn-Off Delay Time (Note 4,5)	$t_{d(off)}$		--	335	--	ns
Turn-Off Fall Time (Note 4,5)	t_f		--	58	--	ns
Total Gate Charge (Note 4,5)	Q_g	V_{DS} = 400V, I_D = 23 A, V_{GS} = 10 V	--	66	--	nC
Gate-Source Charge (Note 4,5)	Q_{gs}		--	20	--	nC
Gate-Drain Charge (Note 4,5)	Q_{gd}		--	17	--	nC
SOURCE DRAIN DIODE						
Maximum Continuous Drain-Source Diode Forward Current	I_S	---	--	--	23	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}	---	--	--	92	A
Drain-Source Diode Forward Voltage	V_{SD}	V_{GS} = 0 V, I_S = 23 A	--	--	1.5	V
Reverse Recovery Time (Note 4)	t_{rr}	V_{GS} = 0 V, I_S = 23 A, dI_F / dt = 100 A/µs	--	417	--	ns
Reverse Recovery Charge (Note 4)	Q_{rr}		--	5.5	--	µC

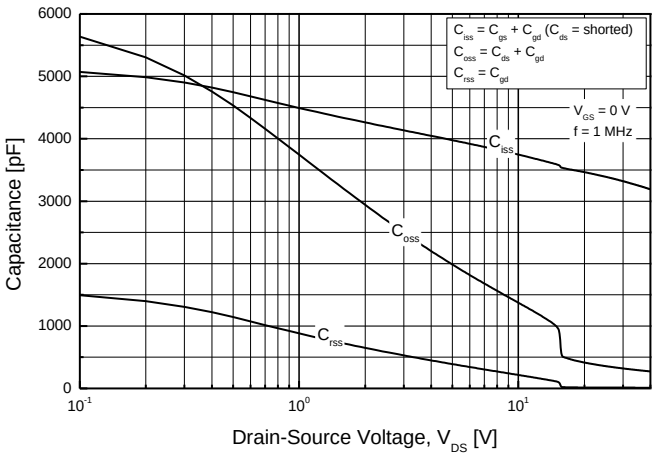
Note :
1. Repeated rating : Pulse width limited by safe operating area
2. L=3.3mH, I_{AS} = 23A, V_{DD} = 50V, R_G = 25Ω, Starting T_J= 25 ℃
3 I_{SD} ≤ 23A, di/dt ≤ 200A/µs , V_{DD} ≤ BV_{DS}, Starting T_J= 25 ℃
4. Pulse Test :Pulse width ≤ 300µs, Duty Cycle ≤ 2%
5. Essentially Independent of Operating Temperature Typical Characteristics

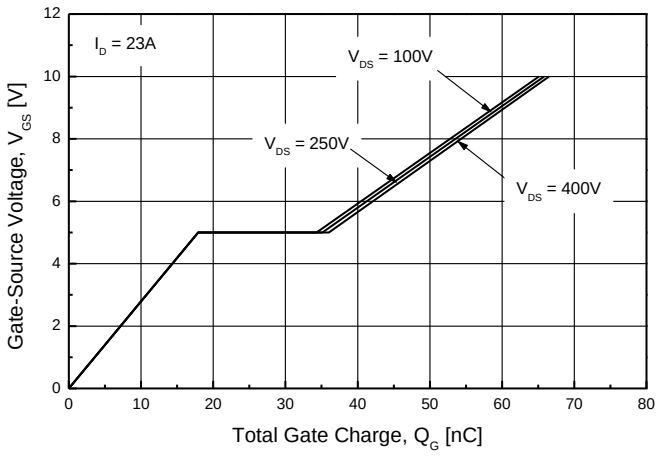

Top V_GS=15.0V
10.0V
8.0V
7.0V
6.5V
6.0V
Bottom 5.0V
1. T_C = 25℃
2. 250μs Pulse Test
Drain Current, I_D [A]
Drain-Source Voltage, V_DS [V]

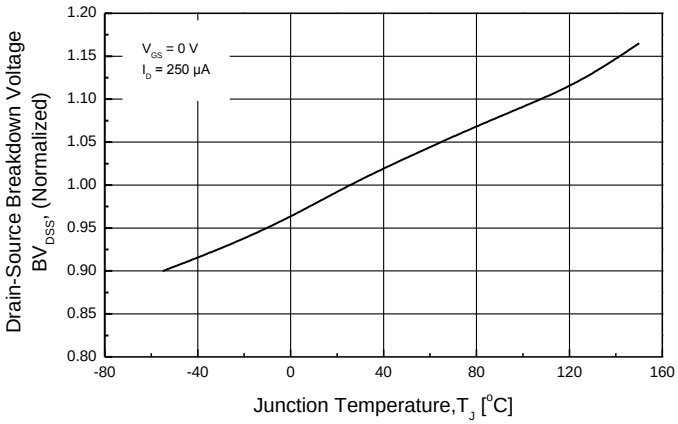

V_DS = 30V
250 μs Pulse Test
150℃
25℃
-55℃
Drain Current, I_D [A]
Gate-Source Voltage, V_GS [V]

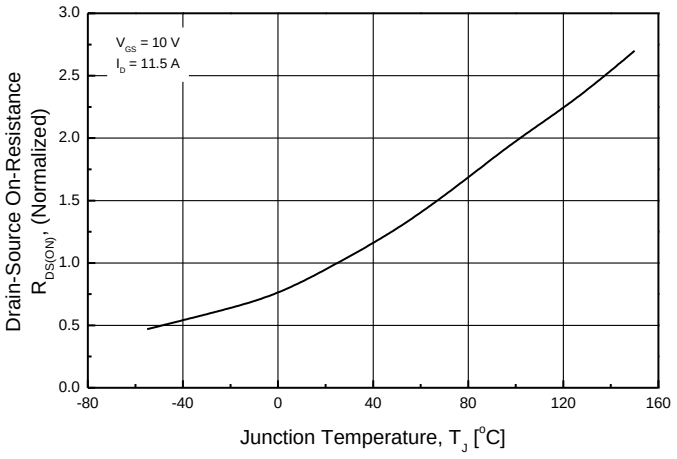

T_J = 25℃
V_GS = 10V
V_GS = 20V
Drain-Source On-Resistance
R_DS(ON) [Ω]
Drain Current, I_D [A]

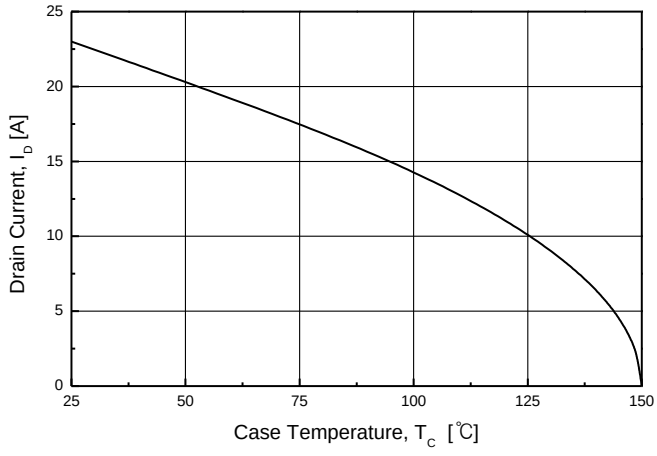

V_GS = 0V
250μs Pulse Test
150℃
25℃
Reverse Drain Current, I_DR [A]
Source-Drain Voltage, V_SD [V]

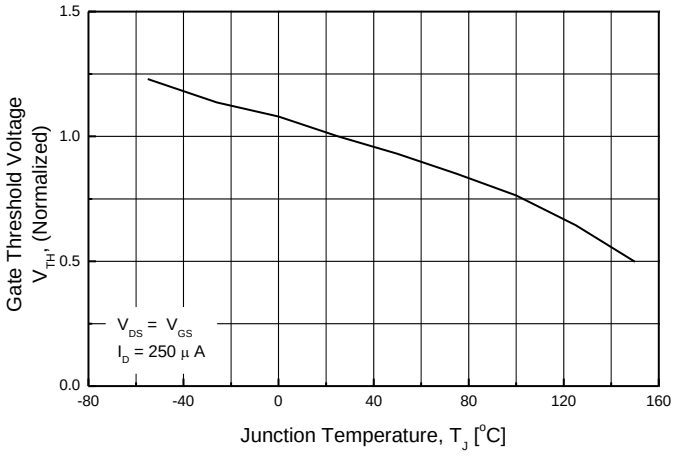

C_iss = C_gs + C_gd (C_ds = shorted)
C_oss = C_ds + C_gd
C_rss = C_gd
V_GS = 0 V
f = 1 MHz
C_iss
C_oss
C_rss
Capacitance [pF]
Drain-Source Voltage, V_DS [V]

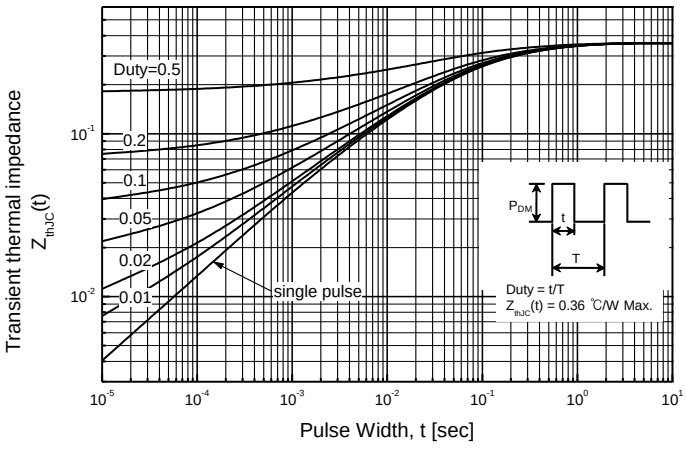

I_D = 23A
V_DS = 100V
V_DS = 250V
V_DS = 400V
Gate-Source Voltage, V_GS [V]
Total Gate Charge, Q_G [nC]

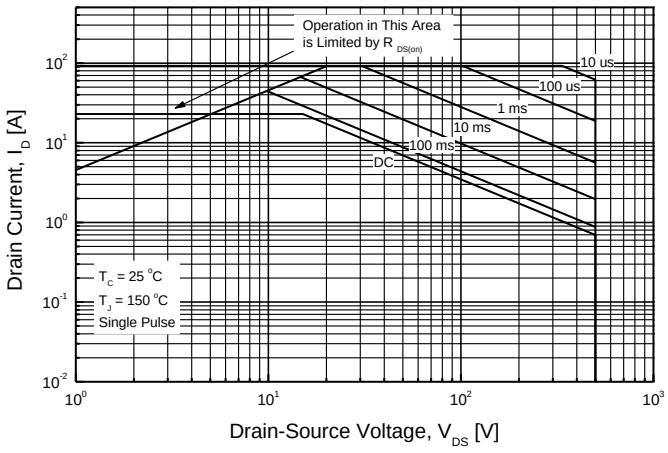

Drain-Source Breakdown Voltage
BV_{DSS}, (Normalized)
V_{GS} = 0 V
I_D = 250 μA
Junction Temperature,T_J [°C]


Drain-Source On-Resistance
$R_{DS(ON)}$, (Normalized)
V_{GS} = 10 V
I_D = 11.5 A
Junction Temperature, T_J [°C]

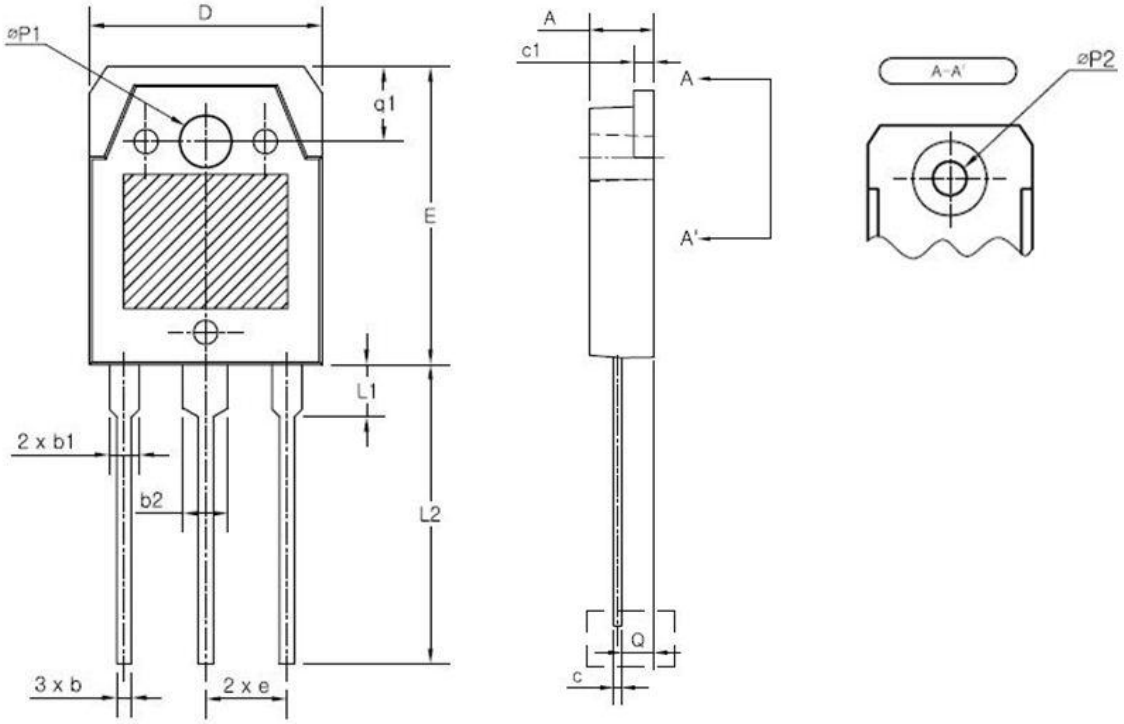

Drain Current, I_D [A]
Case Temperature, T_C [℃]


Gate Threshold Voltage
V_{TH}, (Normalized)
V_{DS} = V_{GS}
I_D = 250 μ A
Junction Temperature, T_J [°C]


Transient thermal impedance
$Z_{thJC}(t)$
Duty=0.5
0.2
0.1
0.05
0.02
0.01
single pulse
P_{DM}
t
T
Duty = t/T
$Z_{thJC}(t)$ = 0.36 ℃/W Max.
Pulse Width, t [sec]


Operation in This Area
is Limited by $R_{DS(on)}$
10 us
100 us
1 ms
10 ms
100 ms
DC
T_C = 25 °C
T_J = 150 °C
Single Pulse
Drain Current, I_D [A]
Drain-Source Voltage, V_{DS} [V]

TO-3PN MECHANICAL DATA



SYMBOL	MIN	NOM	MAX
A	4.60	4.80	5.00
b	0.80	1.00	1.20
b1	1.80	2.00	2.20
b2	2.80	3.00	3.20
c	0.55	0.60	0.75
c1	1.45	1.50	1.65
D	15.40	15.60	15.80
E	19.70	19.90	20.10
e	5.15	5.45	5.75
L1	3.30	3.50	3.70
L2	19.80	20.00	20.20
øP1	3.30	3.40	3.50
øP2		(3.20)	
Q	2.20	2.40	2.60
q1	4.80	5.00	5.20